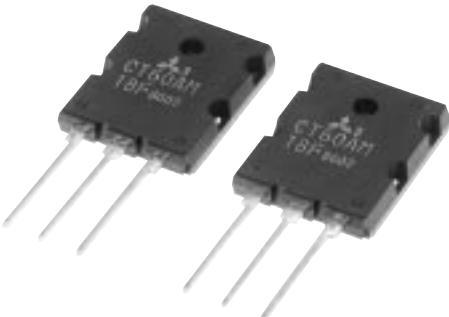
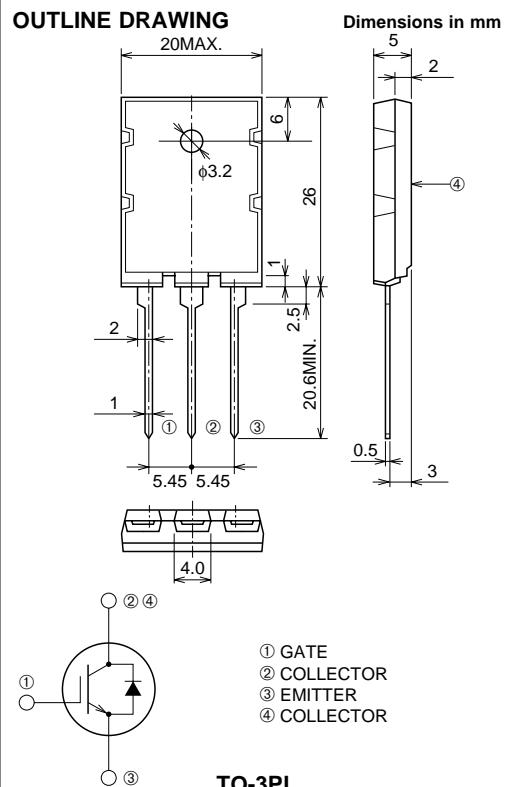


**CT60AM-18F**

INSULATED GATE BIPOLAR TRANSISTOR

**CT60AM-18F**

- VCES ..... 900V
- IC ..... 60A
- Simple drive
- Integrated Fast-recovery diode
- Small tail loss
- Low VCE Saturation Voltage

**OUTLINE DRAWING****APPLICATION**

Microwave oven, Electromagnetic cooking devices, Rice-cookers

**MAXIMUM RATINGS** ( $T_C = 25^\circ\text{C}$ )

Symbol	Parameter	Conditions	Ratings	Unit
V <sub>CES</sub>	Collector-Emitter Voltage	$V_{GE} = 0\text{V}$	900	V
V <sub>GES</sub>	Gate-Emitter Voltage		$\pm 25$	V
V <sub>GEM</sub>	Peak Gate-Emitter Voltage		$\pm 30$	V
I <sub>C</sub>	Collector Current		60	A
I <sub>CM</sub>	Collector Current (Pulse)		120	A
I <sub>E</sub>	Emitter Current		40	A
P <sub>C</sub>	Maximum Power Dissipation		180	W
T <sub>j</sub>	Junction Temperature		$-40 \sim +150$	$^\circ\text{C}$
T <sub>stg</sub>	Storage Temperature		$-40 \sim +150$	$^\circ\text{C}$

## INSULATED GATE BIPOLAR TRANSISTOR

ELECTRICAL CHARACTERISTICS (T<sub>ch</sub> = 25°C)

Symbol	Parameter	Test conditions	Limits			Unit
			Min.	Typ.	Max.	
I <sub>CES</sub>	Collector cutoff current	V <sub>CE</sub> = 900V, V <sub>GE</sub> = 0V	—	—	1.0	mA
I <sub>GES</sub>	Gate leakage current	V <sub>GE</sub> = ±20V, V <sub>CE</sub> = 0V	—	—	0.5	µA
V <sub>GE(th)</sub>	Gate-emitter threshold voltage	V <sub>CE</sub> = 10V, I <sub>C</sub> = 6mA	2.0	4.0	6.0	V
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	I <sub>C</sub> = 60A, V <sub>CE</sub> = 15V	—	2.1	2.7	V
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz	—	4400	—	pF
C <sub>oes</sub>	Output capacitance		—	115	—	pF
C <sub>res</sub>	Reverse transfer capacitance		—	75	—	pF
t <sub>d(on)</sub>	Turn-on deray time	V <sub>CC</sub> = 300V, I <sub>C</sub> = 60A, V <sub>GE</sub> = 15V, R <sub>G</sub> = 10Ω	—	0.05	—	µs
t <sub>r</sub>	Turn-on rise time		—	0.1	—	µs
t <sub>d(off)</sub>	Turn-off delay time		—	0.2	—	µs
t <sub>f</sub>	Turn-off fall time		—	0.2	—	µs
E <sub>tail</sub>	Tail loss	I <sub>CP</sub> = 60A, T <sub>j</sub> = 125°C, dv/dt = 200V/µs	—	0.6	1.0	mJ/pls
I <sub>tail</sub>	Tail current		—	8	12	A
V <sub>EC</sub>	Emitter-collector voltage	I <sub>E</sub> = 60A, V <sub>GE</sub> = 0V	—	2.2	3.0	V
t <sub>rr</sub>	Diode reverse recovery time	I <sub>E</sub> = 60A, dis/dt = -20A/µs	—	0.5	2.0	µs
R <sub>th(j-c)</sub>	Thermal resistance (IGBT)	Junction to case	—	—	0.69	°C/W
R <sub>th(j-c)</sub>	Thermal resistance (Diode)	Junction to case	—	—	4.0	°C/w